

Description

Features

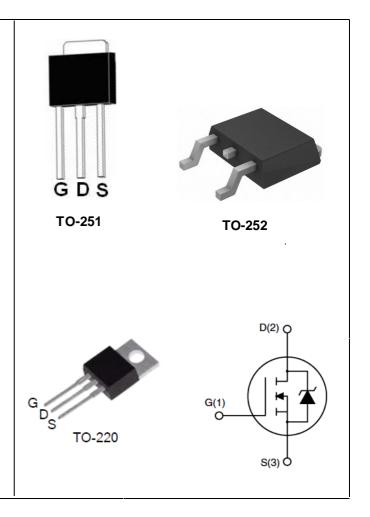
•

VDSS	RDS(ON) @10V (typ)	lo		
200V	0.136Ω	18A		

- Fast switching
- 100% avalanche tested
- Improved dv/dt capability

Application

- DC-DC & DC-AC Converters for telecom, industrial and consumer environment
- Uninterruptible Power Supply (UPS)
- Switch Mode Low Power Supplies
- Industrial Actuators



Absolute Maximum Ratings $T_c=25^{\circ}C$ unless otherwise specified

Symbol	Parameter		Max.			Units
			TO-220	TO-251	TO-252	Units
V _{DSS}	Drain-Source Voltage		200			V
V _{GSS}	Gate-Source Voltage		± 30			V
I _D	Continuous Drain Current	T _C = 25°C	18	18*	18*	Α
		T _C = 100°C	11.45	11.45*	11.45*	Α
I _{DM}	Pulsed Drain Current note1		72	72*	72*	Α
E _{AS}	Single Pulsed Avalanche Energy note2		320			mJ
dv/dt	Peak Diode Recovery Energy note3		8			V/ns
P _D	Power Dissipation	T _C = 25°C	110	65.8	65.8	W
	Linear Derating Factor	T _C > 25℃	0.89	0.53	0.53	W/℃
R _{0JC}	Thermal Resistance, Junction to Case		1.12	1.9	1.9	℃W
T _J , T _{STG}	Operating and Storage Temperature Range		-55 to +150			$^{\circ}$

^{*}Drain current limited by maximum junction temperature



Electrical Characteristics T_c =25 $^{\circ}$ C unless otherwise specified

Symbol	Parameter	Test Condition	Min.	Тур.	Max.	Units
Off Charac	teristic					
V _{(BR)DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0V, I_D = 250Ma$	200	-	-	V
$\triangle V_{(BR)DSS}$	Breakdown Voltage Temperature	Reference to 25℃,	-	0.3	-	V/°C
$/\triangle T_J$	Coefficient	I _D = 250μA				
J. Zoro Coto Voltago	Zero Gate Voltage Drain Current	$V_{DS} = 200V, V_{GS} = 0V$	1	-	1	μΑ
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 160V, T_{C} = 125^{\circ}C$	1	-	10	μΑ
I _{GSS}	Gate to Body Leakage Current	$V_{DS} = 0V, V_{GS} = \pm 20V$	•	-	±100	nA
On Charac	teristics					
$V_{GS(th)}$	Gate Threshold Voltage note4	$V_{DS} = V_{GS}, I_D = 250 \mu A$	1	-	3	V
$R_{\text{DS(on)}}$	Static Drain-Source On-Resistance	$V_{GS} = 10V, I_D = 9A$	-	0.136	0.16	Ω
g FS	Forward Transconductance	V _{DS} =30V, I _D = 9A	-	8	-	S
Dynamic C	haracteristics					
C _{iss}	Input Capacitance	V 25V V 0V	-	836	-	pF
Coss	Output Capacitance	$V_{DS} = 25V, V_{GS} = 0V,$ f = 1.0MHz	-	81.2	-	pF
C _{rss}	Reverse Transfer Capacitance		-	3.81	-	pF
Qg	Total Gate Charge	V _{DD} = 160V, I _D = 18A,	-	17.7	-	nC
Q _{gs}	Gate-Source Charge	$V_{GS} = 100V, I_D = 16A,$ $V_{GS} = 10V$	-	3.9	-	nC
Q _{gd}	Gate-Drain("Miller") Charge	VGS = 10 V	-	5.2	-	nC
Switching	Characteristics					
t _{d(on)}	Turn-On Delay Time		-	12.3	-	ns
t _r	Turn-On Rise Time	$V_{DD} = 100V, I_D = 18A,$	-	21.1	-	ns
t _{d(off)}	Turn-Off Delay Time	$R_G = 5\Omega$, $V_{GS} = 10V$	-	22.5	-	ns
t _f	Turn-Off Fall Time		-	7.7	-	ns
Drain-Sour	ce Diode Characteristics and Maximum I	Ratings	1	1		
Is	Maximum Continuous Drain to Source Diode Forward Current		-	-	18	Α
I _{SM}	Maximum Pulsed Drain to Source Diode Forward Current			-	72	Α
V _{SD}	Drain to Source Diode Forward Voltage	V _{GS} = 0V, I _S = 9A	-	-	1.5	V
t _{rr}	Reverse Recovery Time	$V_{GS} = 0V, I_F = 18A,$	-	235	-	ns
Q _{rr}	Reverse Recovery Charge	di/dt =100A/µs	-	1045	-	nC

Notes:

^{1.} Repetitive Rating: Pulse width limited by maximum junction temperature

^{2.} L = 10mH, I_{AS} = 8A, V_{DD} = 50V, R_G = 25 Ω , Starting T_J = 25 $^{\circ}$ C

^{3.} $I_{SD} \le 18A$, di/dt $\le 200A/\mu s$, $V_{DD} \le B_{VDSS}$, Starting $T_J = 25$ °C

^{4.} Pulse width $\leq 300 \mu s$; duty cycle $\leq 2\%$.



Typical Performance Characteristics

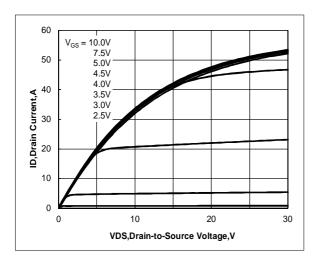


Figure 1. Output Characteristics

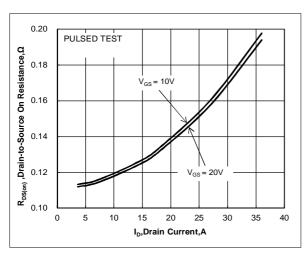


Figure 3. Drain-to-Source On Resistance vs.

Drain Current and Gate Voltage

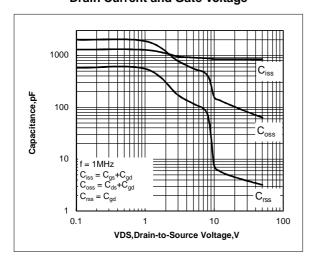


Figure 5. Capacitance Characteristics

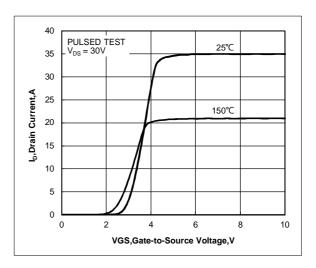


Figure 2. Transfer Characteristics

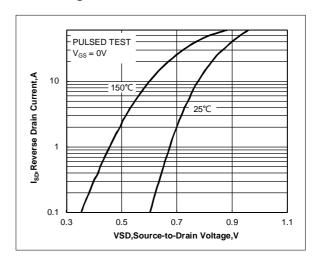


Figure 4. Body Diode Forward Voltage vs.

Source Current and Temperature

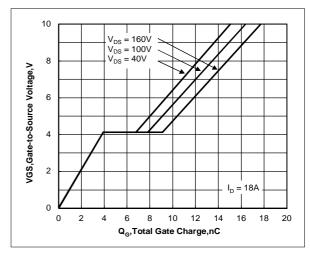


Figure 6. Gate Charge Characteristics



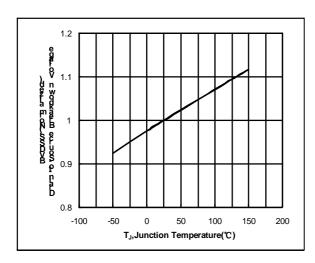


Figure 7. Normalized Breakdown Voltage vs.

Junction Temperature

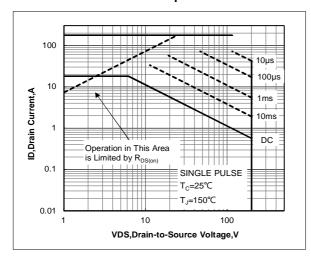


Figure 9. Maximum Safe Operating Area

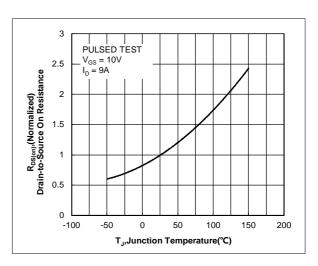


Figure 8. Normalized On Resistance vs.

Junction Temperature

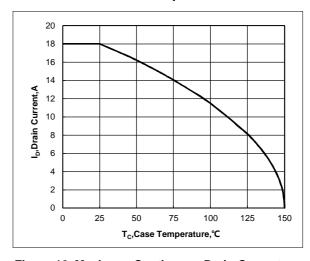


Figure 10. Maximum Continuous Drain Current vs.

Case Temperature

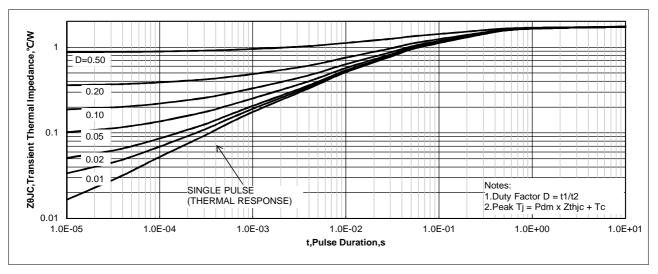


Figure 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

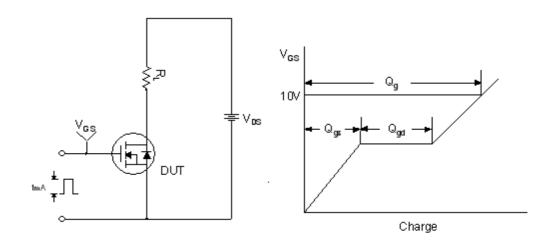


Figure 12. Gate Charge Test Circuit & Waveform

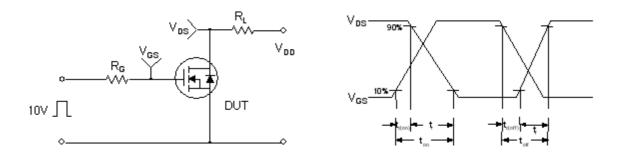


Figure 13. Resistive Switching Test Circuit & Waveforms

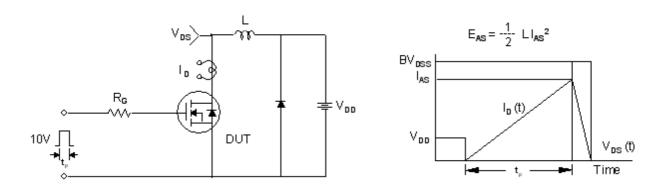
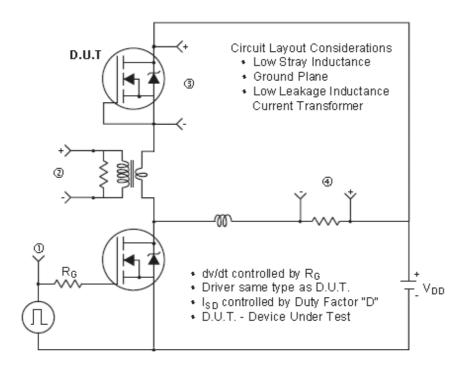


Figure 14. Unclamped Inductive Switching Test Circuit & Waveforms



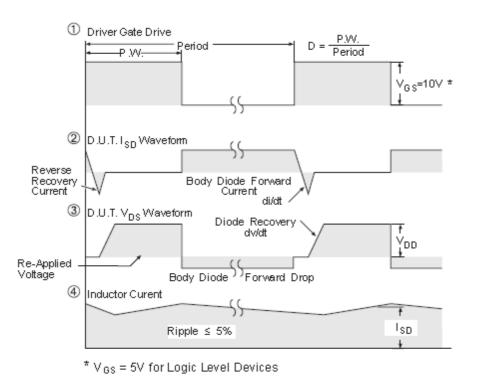


Figure 15. Peak Diode Recovery dv/dt Test Circuit & Waveforms (For N-channel)